Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10571866	VEELAERT ET AL.
Examiner	Art Unit
YUN QIAN	4162

SEARCHED			
Class	Subclass	Date	Examiner
	EAST search in PG-pub, PAT, Dewent, EPO and JPO; 536/128 text and 127/65, 67, 71 text.	7/7/2008	yq
	Consult with Curtis Mayes	7/8/2008	yq
536	128	4/23/2009	yq

SEARCH NOTES		
Search Notes	Date	Examiner
Updated search	4/23/09	yq

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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